

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHIMAMURA ET AL.	
		Examiner Mark Ruthkosky	Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,049,030	05-2006	Eylem et al.	429/220
*	B	US-6,265,105	07-2001	Tokuda et al.	429/206
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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